

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under
	09/215,421	Reexamination CHANG ET AL.
	Examiner	Art Unit
	William C. Schultz	2664

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5,530,367	06-1996	Bottman, Jeffrey S.	324/520
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	E	US-5,363,366	11-1994	Wisdom et al.	370/245
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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